

Product Change Notification / GBNG-16RJZN641

Date:

21-Dec-2020

Product Category:

Memory

PCN Type:

Manufacturing Change

Notification Subject:

CCB 4279.001 Initial Notice: Qualification of GTK as a new assembly site for selected SST38VF640xx, SST39LF40xx and SST39VF40xx device families available in 48L TSOP (12x20mm) package.

Affected CPNs:

GBNG-16RJZN641_Affected_CPN_12212020.pdf GBNG-16RJZN641_Affected_CPN_12212020.csv

Notification Text:

PCN Status: Initial notification

PCN Type: Manufacturing Change

Microchip Parts Affected: Please open one of the icons found in the Affected CPNs section above.

NOTE: For your convenience Microchip includes identical files in two formats (.pdf and .xls).

Description of Change: Qualification of GTK as a new assembly site for selected SST38VF640xx, SST39LF40xx and SST39VF40xx device families available in 48L TSOP (12x20mm) package.

Pre Change:

Assembled at LPI assembly site using 8340 die attach and G700 molding compound material in 162 x 260 or 160x130 mils paddle size

Post Change:

Assembled at GTK assembly site using EN-4900GC die attach and G600F molding compound material in 330 x 260 or 280 x

210 mils paddle size.

Pre and Post Change Summary:

	Pre Cl	hange	Post Change				
Assembly Site	Lingsen Precis LT (Ll		GREATEK ELETRONIC INC. (GTK)				
Wire material	A	u	Au				
Die attach material	83	40	EN-4900GC				
Molding compound material	G7	00	G600F				
Lead frame material	C7()25	C7(025			
Lead frame paddle size	162 x 260	160x130	330 x 260	280 x 210			

Impacts to Data Sheet: None

Change Impact:None

Reason for Change: To improve on-time delivery performance by qualifying GTK as a new assembly site.

Change Implementation Status: In Progress

Estimated Qualification Completion Date: January 2021

Note: Please be advised the qualification completion times may be extended because of unforeseen business conditions however implementation will not occur until after qualification has completed and a final PCN has been issued. The final PCN will include the qualification report and estimated first ship date. Also note that after the estimated first ship date guided in the final PCN customers may receive pre and post change parts.

Time Table Summary:

	December				>	January 2021					
Workweek	49	50	51	52		01	02	03	04	05	
Initial PCN Issue Date				Х							
Qual Report Availability										Х	
Final PCN Issue Date										Х	

Method to Identify Change:

Traceability code

Qualification Plan:Please open the attachments included with this PCN labeled as PCN_#_Qual_Plan.

Revision History:July 17, **2020**: Issued initial notification.**December 21**, **2020**: Re-issued initial notification to update the reference CCB number from CCB 4315 to CCB 4279.001. Updated the affected CPN list by adding SST39LF40xx and SST39VF40xx device families. Updated the qualification plan.

The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable products.

Attachments:

PCN_GBNG-16RJZN641_Qual_Plan.pdf PCN_GBNG-16RJZN641_Pre and Post Change Summary.pdf

Please contact your local Microchip sales office with questions or concerns regarding this notification.

Terms and Conditions:

If you wish to <u>receive Microchip PCNs via email</u> please register for our PCN email service at our PCN home page select register then fill in the required fields. You will find instructions about registering for Microchips PCN email service in the PCN FAQ section.

If you wish to <u>change your PCN profile</u>, <u>including opt out</u>, please go to the <u>PCN home page</u> select login and sign into your myMicrochip account. Select a profile option from the left navigation bar and make the applicable selections. Affected Catalog Part Numbers (CPN)

SST38VF6401-90-5C-EKE SST38VF6402-90-5C-EKE SST38VF6403-90-5C-EKE SST38VF6404-90-5C-EKE SST38VF6401-90-5I-EKE SST38VF6402-90-5I-EKE SST38VF6403-90-5I-EKE SST38VF6404-90-5I-EKE SST38VF6401-90-4I-EKE SST38VF6404-90-5I-EKE-NCM SST38VF6401-90-5C-EKE-T SST39LF401C-55-4C-EKE SST39LF402C-55-4C-EKE SST39VF401C-70-4C-EKE SST39VF402C-70-4C-EKE SST39VF401C-70-4I-EKE SST39VF402C-70-4I-EKE SST39LF401C-55-4C-EKE-T SST39LF402C-55-4C-EKE-T SST39VF401C-70-4C-EKE-T SST39VF402C-70-4C-EKE-T SST39VF401C-70-4I-EKE-T SST39VF402C-70-4I-EKE-T



QUALIFICATION PLAN SUMMARY

PCN #: GBNG-16RJZN641

Date: November 23, 2020

Qualification of GTK as a new assembly site for selected SST38VF640xx, SST39LF40xx and SST39VF40xx device families available in 48L TSOP (12x20mm) package.

Purpose: Qualification of GTK as a new assembly site for selected SST38VF640xx, SST39LF40xx and SST39VF40xx device families available in 48L TSOP (12x20mm) package.

	Assembly site	GTK					
	BD Number	TBD					
	MP Code (MPC)	X02031W9XN90					
	Part Number (CPN)	SST38VF6401-90-5C-EKE					
Misc.	MSL information	MSL 3 / 260					
<u>101001</u>	Assembly Shipping Media (T/R, Tube/Tray)	Тгау					
	Base Quantity Multiple (BQM)	96					
	Reliability Site	MTAI					
	CCB No	4279 and 4279.001					
	Paddle size	330 x 260					
	Material	C7025					
	DAP Surface Prep	Ring Plating					
	Treatment	none					
Lood Fromo	Process	stamped					
Lead-Frame	Lead-lock	No					
	Part Number	11-07048-003					
	Lead Plating	Matte Sn					
	Strip Size	40x210mm					
	Strip Density	16u/strip					
Bond Wire	Material	Au					
Die Attech	Part Number	EN-4900GC					
Die Attach	Conductive	Yes					
MC	Part Number	G600F					
	PKG Type	TSOP					
<u>PKG</u>	Pin/Ball Count	48L					
	PKG width/size	12x20mm					

Test Name	Conditions	Sample Size	Min. Qty of Spares per Lot (should be properly marked)	Qty of Lots	Total Units	Fail Accept Qty	Est. Dur. Days	ATE Test Site	REL Test Site	Pkg. Type	Special Instructions
Standard Pb-free Solderability	J-STD-002D ; Perform 8 hour steam aging for Matte tin finish and 1 hour steam aging for NiPdAu finish prior to testing. Standard Pb-free: Matte tin/ NiPdAu finish, SAC solder, wetting temp 245°C for both SMD & through hole packages.	22	5	1	27	> 95% lead coverage	5	MTAI	MTAI	TSOP48L	Standard Pb-free solderability is the requirement. SnPb solderability (backward solderability- SMD reflow
Backward Solderability	J-STD-002D ; Perform 8 hour steam aging for Matte tin finish and 1 hr steam aging for NiPdAu finish prior to testing. Backward: Matte tin/ NiPdAu finish, SnPb solder, wetting temp 215°C for SMD.	22	5	1	27	> 95% lead coverage	5				soldering) is required for any plating related changes and highly recommended for other package BOM changes.
Wire Bond Pull - WBP	Mil. Std. 883-2011	5	0	1	5	0 fails after TC	5	MTAI	MTAI	TSOP48L	30 bonds from a min. 5 devices.
Wire Bond Shear - WBS	CDF-AEC-Q100-001	5	0	1	5		5	MTAI	MTAI	TSOP48L	30 bonds from a min. 5 devices.
Physical Dimensions	Measure per JESD22 B100 and B108	10	0	3	30		5	MTAI	MTAI	TSOP48L	
Lead Integrity	TM2004 B2 JESD22-B105	3									45 leads
External Visual	Mil. Std. 883-2009	All devices prior to submission for qualification testing	0	3	ALL	0	5	MTAI	MTAI	TSOP48L	

Test Name	Conditions	Sample Size	Min. Qty of Spares per Lot (should be properly marked)	Qty of Lots	Total Units	Fail Accept Qty	Est. Dur. Days	ATE Test Site	REL Test Site	Pkg. Type	Special Instructions
Preconditioning - Required for surface mount devices	+150°C Bake for 24 hours, moisture loading requirements per MSL level + 3X reflow at peak reflow temperature per Jedec-STD- 020E for package type; Electrical test pre and post stress at room temp (25°C) MSL3 / 260c	231	15	3	738	0	15	MTAI	MTAI	TSOP48L	Spares should be properly identified. 77 parts from each lot to be used for HAST, uHAST, Temp Cycle test.
HAST	+130°C/85% RH for 96 hours or 110°C/85%RH for 264 hours. Electrical test pre and post stress at -55°C, +25°C, +125°C	77	5	3	246	0	10	MTAI	MTAI	TSOP48L	Spares should be properly identified. Use the parts which have gone through Pre-conditioning.
UHAST	+130°C/85% RH for 96 hrs or +110°C/85% RH for 264 hrs. Electrical test pre and post stress at -55°C, +25°C, +125°C	77	5	3	246	0	10	MTAI	MTAI	TSOP48L	Spares should be properly identified. Use the parts which have gone through Pre-conditioning.
Temp Cycle	-55°C to +125°C for 500 cycles and 1000 cycles Electrical test pre and post stress at -55°C, +25°C, +125°C .; 3 gram force WBP, on 5 devices from 1 lot, test following Temp Cycle stress.	77	5	3	246	0	15	MTAI	MTAI	TSOP48L	Spares should be properly identified. Use the parts which have gone through Pre-conditioning.

CCB 4279.001 Pre and Post Change Summary PCN #: GBNG-16RJZN641

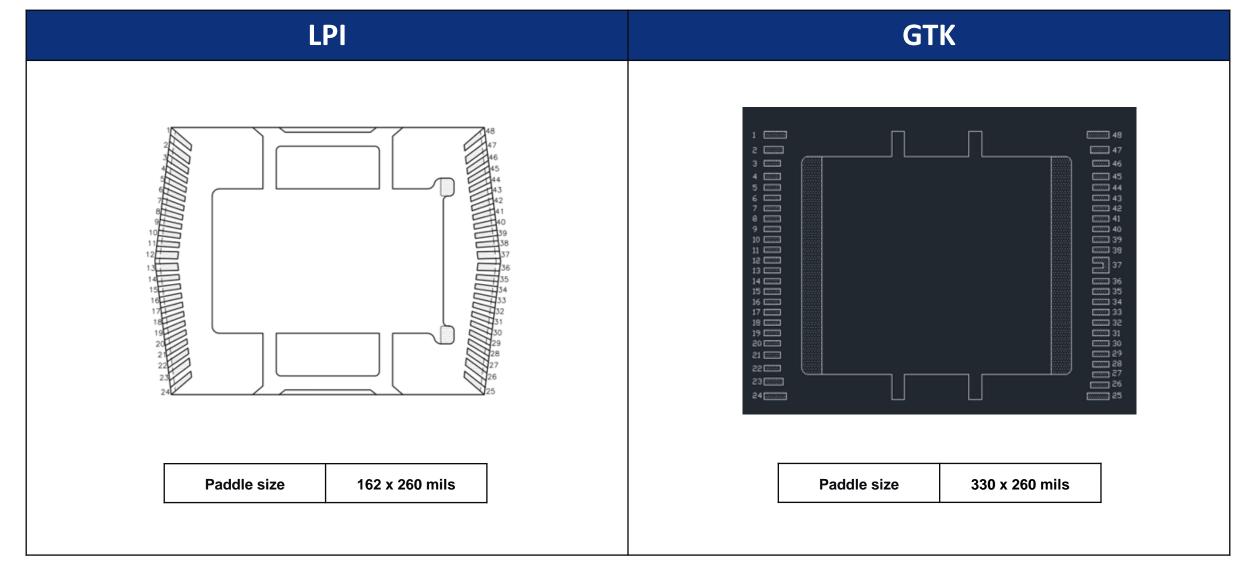


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Lead frame Comparison





Lead frame Comparison

